

# Search Notes



Application/Control No.

10/664,379

Examiner

Long Nguyen

Applicant(s)/Patent under Reexamination

BENZER ET AL.

Art Unit

2816

## SEARCHED

| Class | Subclass  | Date   | Examiner |
|-------|---|--------|----------|
| 327   | 333, 427,<br>581, 112,<br>309, 310,<br>313, 327,<br>328,<br>434-437 | 2/3/05 | LN       |
| 32C   | 68, 81, 80,<br>63   |        |          |
| 365   | 189-11  |        |          |
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## INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

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